## Specification Sheet for Electrochemical Impedance Spectroscopy Setup for Solar Photovoltaic Devices सौर फोटोवोल्टिक उपकरणों के लिए विद्युत रासायनिक प्रतिबाधा स्पेक्ट्रोस्कोपी सेटअप के लिए विवरण पत्र

Here we are looking for a Potenstiostat Galvanostat Impedance Analyzer for the following applications:

1. I-V characteristics of thin films and semiconductor devices (like solar photovoltaic, diode etc.).
2. Impedance spectroscopy of semiconductor devices (like solar photovoltaic, diode etc.).

| S. <br> No. | Particulars | S. <br> No. | Specifications |  |
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| 1 | Power Amplifier | 1.1 | Compliance Voltage | $\geq \pm 25 \mathrm{~V}$ |
|  |  | 1.2 | Maximum Current | $\geq 1 \mathrm{~A}$ |
| 2 | Potentiostat Bandwidth | 2.1 | $\geq 5 \mathrm{MHz}$ |  |
| Potentiostatic Mode |  |  |  |  |
| 3 | Voltage Control | 3.1 | Applied DC Voltage Range | $\pm 10 \mathrm{~V}$ (selectable) |
|  |  | 3.2 | Applied DC Voltage Resolution | $\geq 16$ bit |
|  |  | 3.3 | Maximum DC voltage scan Rate | $\geq 100 \mathrm{~V} / \mathrm{sec}$ |
| 4 | Current <br> Measurement | 4.1 | Measured DC Current Range | 10nA to 1A |
|  |  |  |  | 9 decades (ranges) or more |
|  |  | 4.2 | Measured DC Current resolution | $\geq 16$ bit |
| Galvanostatic Mode |  |  |  |  |
| 5 | Current Control | 5.1 | Applied DC Current Range | 10nA to 1A |
|  |  |  |  | 9 decades (ranges) or more |
|  |  | 5.2 | Applied DC Current resolution | $\geq 16$ bit |
| 6 | Voltage <br> Measurement | 6.1 | Measured DC Voltage Range | $\pm 10 \mathrm{~V}$ |
|  |  | 6.2 | Measured DC Voltage Resolution | $\geq 16$ bit |
| 7 | Leakage Current Or Input Bias Current | 7.1 | $\leq 10 \mathrm{pA}$ |  |
| Electrochemical Impedance Spectroscopy (EIS) Mode |  |  |  |  |
| 8 | Impedance (EIS mode) | 8.1 | Mode | Potentiostatic and Galvanostatic |
|  |  | 8.2 | Frequency Range | $10 \mu \mathrm{HZ}$ to $\geq 5 \mathrm{MHz}$ |
|  |  | 8.3 | Frequency Resolution | 10 to 100 steps / decade |
|  |  | 8.4 | Maximum Input Voltage range | $\pm 10 \mathrm{~V}$ |
|  |  | 8.5 | Input Impedance | $\geq 1$ Tohm in parallel with $\leq 10 \mathrm{pF}$ |
|  |  | 8.6 | Applied AC amplitude | $\leq 1 \mathrm{mV} \mathrm{rms} \mathrm{to} \geq 100 \mathrm{mV} \mathrm{rms}$ |
|  |  | 8.7 | AC voltage resolution | $\leq 0.5 \mathrm{mV}$ |
|  |  | 8.8 | Swipe Mode | Linear and Logarithmic |
| 9 | Cell Connections | 9.1 | Cell / Electrode Connections | 2, 3, 4 (WE, S, CE, RE) and ground electrode |
|  |  | 9.2 | End Connectors with cables | Following types of end connectors are required: <br> 1. Crocodile Clips <br> 2. Male type BNC connection (both for each connection) <br> 3. Proper required connectors to be given for converting connections from 4 to 2 probe connections <br> (Note: we have probe setup with panel mounted female BNC connections) |
| 10 | Data Acquisition | 10.1 | A/D converter (ADC) | $\geq 16$ bit |
|  |  | 10.2 | D/A converter (DAC) | $\geq 16$ bit |
| 11 | Interface to PC | 11.1 | USB (with required cable length for connection between PC to instrument and with matching end connectors at both ends) |  |
| 12 | Dummy Cell | 12.1 | External Dummy Cell should be provided with the instrument for testing purpose |  |
| 13 | Power Requirement | 13.1 | Total Maximum Power | $\leq 1000 \mathrm{~W}$ |
|  |  | 13.2 | Mains Input | 230V, 50Hz, Single Phase AC, Indian Standards |
|  |  | 13.3 | Connection | 3 pin top plug as per Indian Standards |


| 14 | PC (Computer Specification) | 14.1 | A suitable computer desktop with minimum 21 inch LED monitor OR a laptop with minimum of 15 inch LED screen should be provided with instrument. |
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|  |  | 14.2 | Licensed windows 10 Professional should be provided with computer |
|  |  | 14.3 | Microprocessor: i5-10th generation or higher version |
|  |  | 14.4 | Hard Disk : $\geq 500 \mathrm{~GB}$ |
|  |  | 14.5 | appropriate required USB ports for connection of instrument |
|  |  | 14.6 | USB mouse (in case of desktop) |
|  |  | 14.7 | USB Key board (in case of desktop) |
|  |  | 14.8 | One spare USB port and One spare HDMI port should be available |
|  |  | 14.9 | All necessary power and other cables and connections should be provided. |
| 15 | Software | 15.1 | software for all measurement, fitting, analysis etc. should be provided |
|  |  | 15.2 | software should have proper user friendly graphic environment for plotting, overlay, fitting, analysis, simulation etc. |
|  |  | 15.3 | Control of all the hardware should be done through software |
|  |  | 15.4 | Data Analysis - Capability of Real Time fit, equivalent circuit fitting, Simulation etc. |
|  |  | 15.5 | Compatible to Windows 10 operating system |
|  |  | 15.6 | License - Lifetime |
| 16 | Type of Measurements | 16.1 | Cyclic Voltammetry |
|  |  | 16.2 | Electrochemical Impedance Spectroscopy (EIS) |
|  |  | 16.3 | Linear Sweep Voltammetry |
|  |  | 16.4 | Chrono Techniques (Voltammetry + Amperometry) |
| 17 | Measurements of Solar Photovoltaic Device | 17.1 | Current - DC bias Voltage (I-V) |
|  |  | 17.2 | Capacitance - DC bias Voltage (C-V) with various frequencies |
|  |  | 17.3 | Mott Schottky analysis ( $1 / \mathrm{C}^{2}-\mathrm{V}$ ) with various frequencies |
|  |  | 17.4 | Capacitance - Frequency (C-f) with various biasing voltage |
|  |  | 17.5 | Imaginary Impedance - Real Impedance ( $\mathrm{Z}_{\mathrm{im}}-\mathrm{Z}_{\mathrm{re}}$ ) with various frequencies (i.e. Nyquist Plot / Cole-Cole plot) |
|  |  | 17.6 | Impedance - Frequency (Z-f) (i.e. Bode Plot) |
|  |  | 17.7 | Current - Time (I-t) |
|  |  | 17.8 | Voltage - Time (V-t) |
| 18 | Warranty and Service | 18.1 | Minimum One Year warranty from the date of installation |
|  |  | 18.2 | Supplier should provide onsite warranty and service support. |
| 19 | Scope of Vendor | 19.1 | Fabricate / Supply \& Testing of setup |
|  |  | 19.2 | Installation and commissioning at FCIPT, IPR, Demonstration on IPR's thin film solar photovoltaic device sample |
|  |  | 19.3 | Operation Training to IPR personnel at IPR site (FCIPT campus) |
| 20 | Delivery Time | 20.1 | 12 weeks from the date of P.O. |
| 21 | Installation | 21.1 | 2 weeks from the date of delivery |
| 22 | Factory Acceptance Test | 22.1 | Following test should be conducted using external dummy cell available with the instrument and results of the test should be sent to IPR for approval before dispatch: <br> 1. DC measurement: <br> a. Connect the instrument to the resister in the range of 1 MOhm (as per available in dummy cell) in the dummy cell and swipe the voltage from -10 V to +10 V (in equidistance 100 points) and record the current. Data should be sent in excel file format with screen shot of the measurement for approval of dispatch. <br> b. Connect the instrument to the resister in the range of 1 KOhm (as per available in dummy cell) in the dummy cell and swipe the voltage from - 10 V to +10 V (in equidistance 100 points) and record the current. Data should be sent in excel file format with screen shot of the measurement for approval of dispatch. <br> 2. EIS measurement: <br> a. Connect the instrument to the Randle circuit of the dummy cell and measure the impedance (i.e. Nyquist Plot) for $10 \mu \mathrm{~Hz}$ to 1 MHz frequency range and calculate the value of circuit components (i.e. series resistance (100-1000 Ohm as per available in dummy cell), parallel resistance (1-10 KOhm as per available in dummy cell) and capacitance ( $\sim 1 \mu \mathrm{~F}$ as per available in dummy cell)) by fitting the measured data using the software. Data should be sent in excel file format with screen shot of the measurement for approval of dispatch. |


| 23 | Acceptance Criteria (Testing at IPR) | 23.1 | Testing will be performed by vendor's engineer at IPR in presence of IPR's technical person. <br> Following tests will be done for resistivity measurement using I-V characteristics: <br> 1. I-V test for the range of instrument with different resistors in potentiostatic and galvanostatic mode (2-probe measurements) <br> a. 1 Ohm or less to 10 Ohm for lower voltage (1V range) and higher current range (1 A range) <br> b. $100 \mathrm{Ohm}-10 \mathrm{KOhm}$ for mid voltage ( 5 V range) and mid current range (10 mA range) <br> c. 1 MOhm for higher voltage ( 10 V range) and lower current ( 10 nA range) <br> 2. Measurement of Sheet resistance of thin film using 4-probe setup to test the working in four probe mode. (galvanostatic mode) (Note: four probe setup and metallic thin film will be provided by the IPR with four banana lugs to connect to the instrument) <br> 3. Following tests will be performed at external dummy cell and IPR provided photovoltaic cell (CZTS absorber based thin film solar cell) in impedance (EIS) mode: <br> a. I-V characteristics of the cell (as per PN junction) <br> b. Mott Schottky analysis $\left(1 / \mathrm{C}^{2}-\mathrm{V}\right)$ where voltage is applied -5 to +5 V and Capacitance is measured with various frequencies $100 \mathrm{~Hz}, 1 \mathrm{KHz}, 10 \mathrm{KHz}$, $100 \mathrm{KHz}, 1 \mathrm{MHz}, 5 \mathrm{MHz}$ <br> c. Capacitance - Frequency (C-f) where frequency is varied from 100 Hz to 5 MHz in steps decades with various biasing voltage(-5V to +5 V ) <br> d. Imaginary Impedance - Real Impedance ( $\mathrm{Z}_{\mathrm{im}}-\mathrm{Z}_{\mathrm{re}}$ ) with various frequencies (from $10 \mu \mathrm{~Hz}$ to 5 MHz with variation of 10 to 100 points in every decade) (i.e. Nyquist Plot / Cole-Cole plot) <br> e. Impedance - Frequency (Z-f) (i.e. Bode Plot) for the same range as mentioned above. |
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